

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	09/944,501	KON ET AL.	
	Examiner	Art Unit	Page 1 of 1
Cristina Owen Sherr	3621		

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,990,684	01-2006	Futamura et al.	726/18
*	C	US-7,100,044	08-2006	Watanabe et al.	713/156
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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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